

# BUL312FH HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

Ordering Code	Marking	Shipment
BUL312FH	BUL312FH	Tube

- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- FULLY CHARACTERIZED AT 125 °C
- LARGE R.B.S.O.A.
- FULLY INSULATED PACKAGE (U.L. COMPLIANT) FOR EASY MOUNTING

### **APPLICATIONS:**

- HORIZONTAL DEFLECTION FOR COLOR TV
- SWITCH MODE POWER SUPPLIES
- ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

### DESCRIPTION

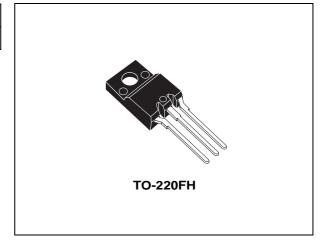
The device is manufactured using High Voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capability.

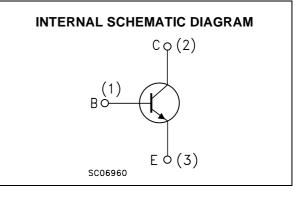
It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining a wide R.B.S.O.A.

# **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
VCES	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	1150	V
VCEO	Collector-Emitter Voltage (I <sub>B</sub> = 0)	500	V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	9	V
Ι <sub>C</sub>	Collector Current	5	А
ICM	Collector Peak Current (t <sub>p</sub> < 5 ms)	10	A
I <sub>B</sub>	Base Current	3	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	4	А
P <sub>tot</sub>	Total Dissipation at $T_c = 25 \text{ °C}$	36	W
V <sub>isol</sub> Insulation Withstand Voltage (RMS) from All Three Leads to External Heatsink		2500	V
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Тj	Max. Operating Junction Temperature	150	°C

August 2002





## BUL312FH

#### THERMAL DATA

R <sub>thj-case</sub>	Thermal Resistance Junction-case	Max	3.47	°C/W
R <sub>thj-amb</sub>	Thermal Resistance Junction-ambient	Max	62.5	°C/W

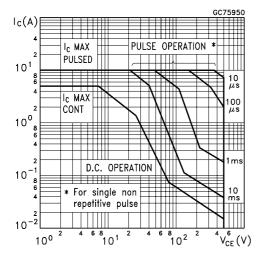
# **ELECTRICAL CHARACTERISTICS** (T<sub>j</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test	Conditions	Min.	Тур.	Max.	Unit
ICES	Collector Cut-off Current (V <sub>BE</sub> = 0)	V <sub>CE</sub> = 1150 V V <sub>CE</sub> = 1150 V	T <sub>j</sub> = 125 °C			1 2	mA mA
I <sub>CEO</sub>	Collector Cut-off Current ( $I_B = 0$ )	V <sub>CE</sub> = 500 V				250	μΑ
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	I <sub>E</sub> = 10 mA		9			V
V <sub>CEO(sus)</sub> *	Collector-Emitter Sustaining Voltage $(I_B = 0)$	I <sub>C</sub> = 100 mA		500			V
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	$I_{C} = 1 A$ $I_{C} = 2 A$ $I_{C} = 3 A$	I <sub>B</sub> = 200 mA I <sub>B</sub> = 400 mA I <sub>B</sub> = 600 mA			0.5 0.7 1.1	V V V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	$I_{C} = 1 A$ $I_{C} = 2 A$ $I_{C} = 3 A$	I <sub>B</sub> = 200 mA I <sub>B</sub> = 400 mA I <sub>B</sub> = 600 mA			1 1.1 1.2	V V V
h <sub>FE</sub> *	DC Current Gain	I <sub>C</sub> = 10 mA I <sub>C</sub> = 3 A	V <sub>CE</sub> = 5 V V <sub>CE</sub> = 2.5 V	8 8		16	
t <sub>s</sub> t <sub>f</sub>	INDUCTIVE LOAD Storage Time Fall Time	$I_{C} = 2 A$ $I_{B1} = 400 \text{ mA}$ $L = 200 \mu H$ (See Figure 1)	$V_{clamp} = 250 V$ $V_{BE(off)} = -5 V$ $R_{BB} = 0$		1.2 80	1.9 160	µs ns
t <sub>s</sub> t <sub>f</sub>	INDUCTIVE LOAD Storage Time Fall Time	$I_{C} = 2 A$ $I_{B1} = 400 \text{ mA}$ $L = 200 \mu\text{H}$ $T_{j} = 125 \text{ °C}$	$V_{clamp} = 250 V$ $V_{BE(off)} = -5 V$ $R_{BB} = 0$ $(See Figure 1)$		1.8 150		µs ns

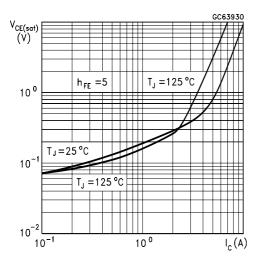
\* Pulsed: Pulse duration = 300  $\mu$ s, duty cycle = 1.5 %.

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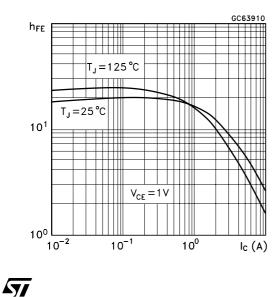
#### Safe Operating Area



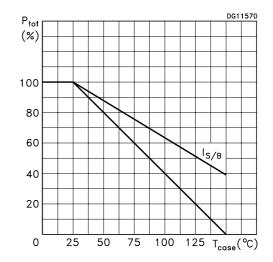
Collector-Emitter Saturation Voltage



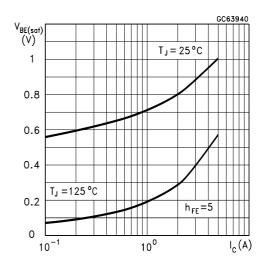
DC Current Gain



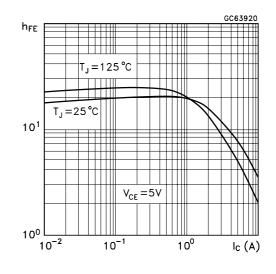
Derating Curve



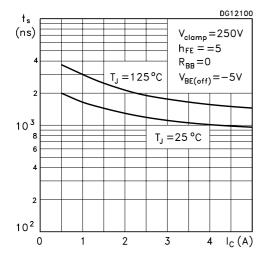








#### Inductive Load Storage Time



Reverse Biased Safe Operating Area

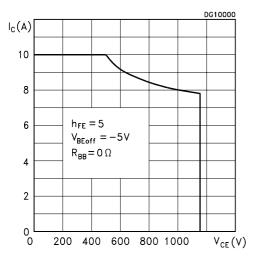
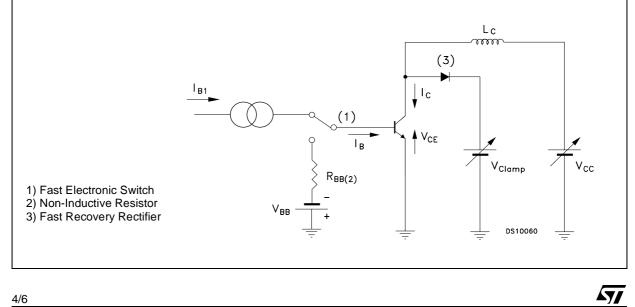
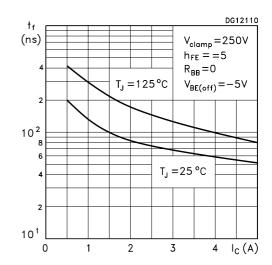


Figure 1: Inductive Load Switching Test Circuit

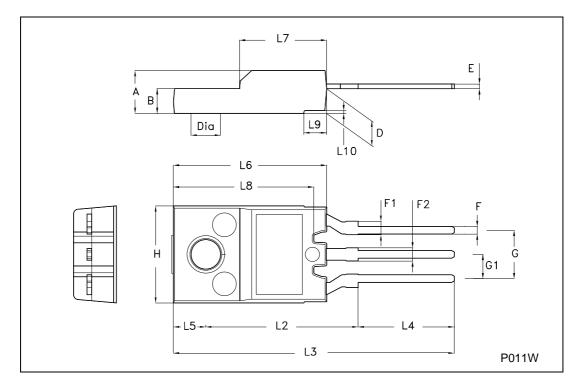


Inductive Load Fall Time



DIM.	mm			inch		
Dilvi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.3		1.8	0.051		0.070
F2	1.3		1.8	0.051		0.070
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	0.385		0.417
L5		3.4			0.134	
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
L8	14.5		15	0.570		0.590





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